

Notice of References Cited	Application/Control No. 09/660,186		Applicant(s)/Patent Under Reexamination KWAK, DONG YEUNG	
	Examiner Steven Loke		Art Unit 2811	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6016174	01-2000	Endo et al.	257/59
	B	US-			
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	D	US-			
	E	US-			
	F	US-			
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	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP-7-66419	03-1995	Japan	Matsuo et al.	257/59
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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